


<b>Search Notes</b> 	<b>Application/Control No.</b> 10596124	<b>Applicant(s)/Patent Under Reexamination</b> TARDIEU, PHILIPPE
	<b>Examiner</b> Bashaw, Heidi M	<b>Art Unit</b> 3732

SEARCHED			
Class	Subclass	Date	Examiner
433	173	11/27/2007	HMB

SEARCH NOTES		
Search Notes	Date	Examiner

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner